Search Notes

•	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/070,617	SAKUMA, EMIKO	
	Examiner	Art Unit	
	Jacob Meek	2637	

SEARCHED					
Class	Subclass	Date	Examiner		
375	140,144 150	1/20/2006	JM		
708	250	1/20/2006	JM		
370	335,311	1/20/2006	JM		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East: see search history	1/20/2006	JM		
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